Power MOSFET

40 V, 0.67 m Ω , 430 A, Single N-Channel

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	٧
Gate-to-Source Voltage			V _{GS}	±20	٧
Continuous Drain	Steady State	T _C = 25°C	I _D	430	Α
Current R _{0JC} (Notes 1, 3)		T _C = 100°C		304	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P_{D}	273	W
		T _C = 100°C	1	136	
Continuous Drain		T _A = 25°C	I _D	51	Α
Current R _{θJA} (Notes 1, 2, 3)	Steady	T _A = 100°C		37	
Power Dissipation	State	T _A = 25°C	P_{D}	3.9	W
R _{θJA} (Notes 1, 2)		T _A = 100°C	1	2.0	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to + 175	°C
Source Current (Body Diode)			Is	1250	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40 A)			E _{AS}	1216	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.10	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30.4	

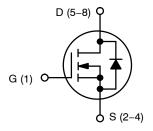
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	0.67 m Ω @ 10 V	430 A



N-CHANNEL MOSFET



DFNW8 TX SUFFIX CASE 507AP

MARKING DIAGRAM



XXX = Device Code

(8 A-N characters max)

A = Assembly Location

WL = 2-digit Wafer Lot Code

Y = Year Code

WW = Work Week Code

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

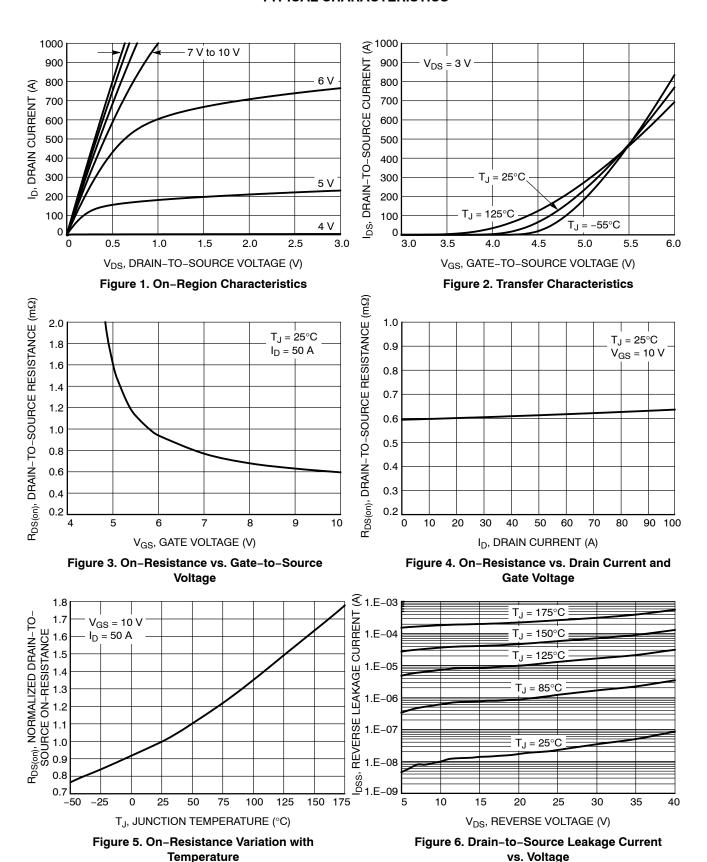
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				20		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}					10	
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		2.0		4.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	·			-8.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.57	0.67	mΩ
Forward Transconductance	9FS	V _{DS} =5 V, I _D = 50 A			200		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			9281		pF
Output Capacitance	C _{OSS}				5387		
Reverse Transfer Capacitance	C _{RSS}				176		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			140		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			22.7		nC
Gate-to-Source Charge	Q _{GS}				37		
Gate-to-Drain Charge	Q_{GD}				28.3		
Plateau Voltage	V_{GP}				4.28		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 20 V, I_{D} = 50 A, R_{G} = 2.5 Ω			28.9		
Rise Time	t _r				18.1		- ns
Turn-Off Delay Time	t _{d(OFF)}				61.0		
Fall Time	t _f				20.4		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 50 A	T _J = 25°C		0.9	1.2	.,,
			T _J = 125°C		0.8		-
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			88.9		ns
Charge Time	t _a				57.9		
Discharge Time	t _b				31		
Reverse Recovery Charge	Q _{RR}				191		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

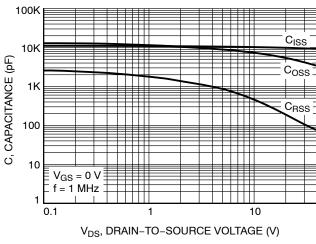


Figure 7. Capacitance Variation

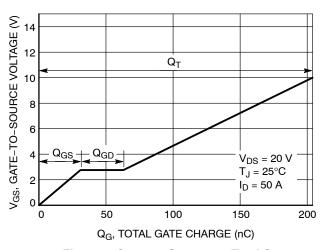


Figure 8. Gate-to-Source vs. Total Gate Charge

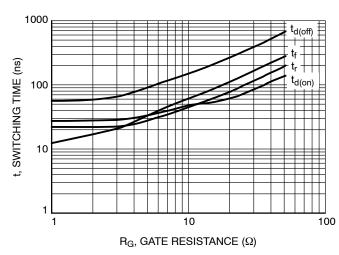


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

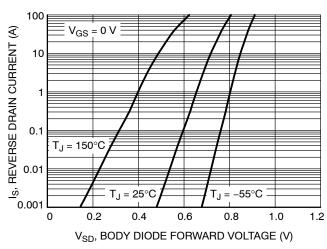


Figure 10. Diode Forward Voltage vs. Current

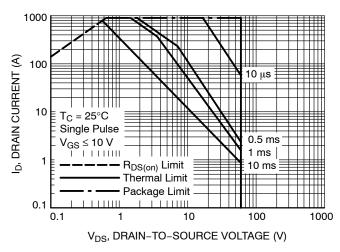


Figure 11. Maximum Rated Forward Biased Safe Operating Area

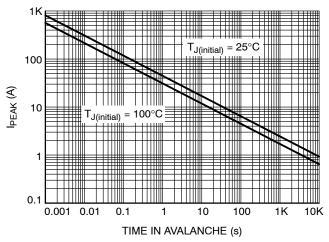


Figure 12. I_{PEAK} vs. Time in Avalanche

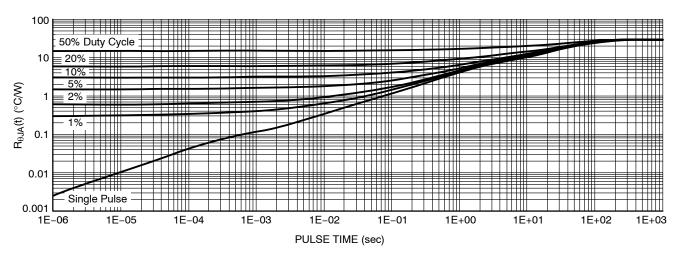


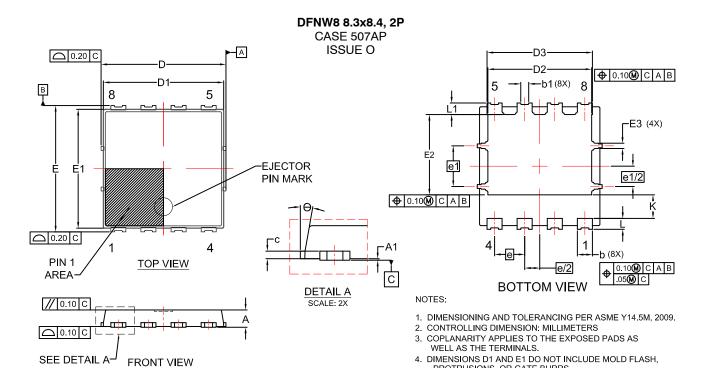
Figure 13. Thermal Characteristics

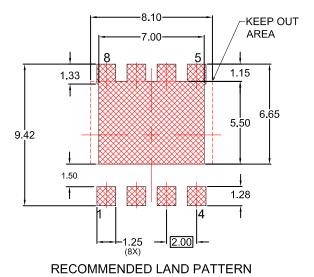
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMTS0D7N04CTXG	0D7N04C	POWER 88 (Pb-Free)	TBD / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS





MILLIMETERS DIM MIN. NOM. MAX. 1.00 1.20 1.10 Α A1 0.00 0.05 1.00 1.10 b 0.90 b1 0.43 0.53 0.63 0.23 0.28 0.33 D 8.20 8.30 8.40 D1 7.90 8.00 8.10 D2 6.80 6.90 7 00 D3 6.90 7.00 7.10 Е 8.30 8.50 8.40 E1 7.80 7.90 8.00 E2 5.34 5.44 5.24 E3 0.35 0.45 0.25 2.00 BSC 1.00 BSC e/2 e1 2.70 BSC 1.35 BSC e1/2 Κ 1.50 1.57 1.70 0.64 0.74 0.84 0.67 0.87 L1 0.77 θ 0° 12°

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"A1" IS DEFINED AS THE DISTANCE FROM THE SEATING
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